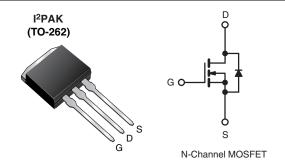


Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	600				
R _{DS(on)} (Ω)	V _{GS} = 10 V 0.75				
Q _g (Max.) (nC)	49				
Q _{gs} (nC)	13				
Q _{gd} (nC)	20				
Configuration	Single				



FEATURES





- Low Gate Charge Q_g Results in Simple Drive Requirement
- Improved Gate, Avalanche and Dynamic dV/dt Ruggedness
- Fully Characterized Capacitance and Avalanche Voltage and Current
- Compliant to RoHS Directive 2002/95/EC

APPLICATIONS

- Switch Mode Power Supply (SMPS)
- Uninterruptable Power Supply
- High Speed Power Switching
- This Device is only for Through Hole Application

APPLICABLE OFF LINE SMPS TOPOLOGIES

- Active Clamped Forward
- Main Switch

ORDERING INFORMATION	
Package	I ² PAK (TO-262)
Lead (Pb)-free and Halogen-free	SiHFSL9N60A-GE3
Lead (Pb)-free	IRFSL9N60APbF
Lead (FD)-life	SiHFSL9N60A-E3

ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)					
PARAMETER			SYMBOL	LIMIT	UNIT
Drain-Source Voltage			V_{DS}	600	V
Gate-Source Voltage			V_{GS}	± 30	V
Continuous Drain Current	V _{GS} at 10 V	$T_C = 25 ^{\circ}C$ $T_C = 100 ^{\circ}C$	I_	9.2	
Continuous Diain Current	Continuous Drain Current V_{GS} at 10 V $T_{C} = 100 ^{\circ}\text{C}$		Ι _D	5.8	Α
Pulsed Drain Current ^a			I _{DM}	37	
Linear Derating Factor				1.3	W/°C
Single Pulse Avalanche Energy ^b			E _{AS}	290	mJ
Repetitive Avalanche Current ^a			I _{AR}	9.2	Α
Repetitive Avalanche Energy ^a			E _{AR}	17	mJ
Maximum Power Dissipation $T_C = 25 ^{\circ}C$			P _D	170	W
Peak Diode Recovery dV/dtc			dV/dt	5.0	V/ns
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	°C
Soldering Recommendations (Peak Temperature)	for	10 s		300 ^d	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Starting $T_J = 25$ °C, L = 6.8 mH, $R_g = 25$ Ω , $I_{AS} = 9.2$ A (see fig. 12). c. $I_{SD} \le 9.2$ A, $dI/dt \le 50$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRFSL9N60A, SiHFSL9N60A

Vishay Siliconix



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient (PCB Mounted, steady-state)	R _{thJA}	-	40	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	0.75		

SPECIFICATIONS (T _J = 25 °C, t	SPECIFICATIONS (T _J = 25 °C, unless otherwise noted)							
PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT		
Static								
Drain-Source Breakdown Voltage	V _{DS}	V _{GS}	= 0, I _D = 250 μA	600	-	-	V	
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} :	= V _{GS} , I _D = 250 μA	2.0	-	4.0	V	
Gate-Source Leakage	I_{GSS}		$V_{GS} = \pm 30 \text{ V}$	i	-	± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}		= 600 V, V _{GS} = 0 V	-	-	25	μA	
Zoro date voltage Brain Garrent	פפעי		/, V _{GS} = 0 V, T _J = 125 °C	ı	-	250	μπ	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	$I_D = 5.5 A^b$	-	-	0.75	Ω	
Forward Transconductance	9 _{fs}	V _{DS} :	= 25 V, I _D = 3.1 A ^b	5.5	-	-	S	
Dynamic		•			ı	1		
Input Capacitance	C _{iss}		$V_{GS} = 0 V$	ı	1400	-		
Output Capacitance	C _{oss}	f_1	V _{DS} = 25 V .0 MHz, see fig. 5	-	180	-]	
Reverse Transfer Capacitance	C_{rss}	1=1	.0 MHz, see lig. 5	-	7.1	-	pF	
Output Capacitance	C _{oss}	V _{GS} = 0 V	V _{DS} = 1.0 V, f = 1.0 MHz	-	1957	-	- ρι -	
Cutput Capacitance			$V_{DS} = 480 \text{ V, f} = 1.0 \text{ MHz}$	-	49	-		
Effective Output Capacitance	C _{oss} eff.		V _{DS} = 0 V to 480 V ^c	-	96	-		
Total Gate Charge	Q_g			-	-	49		
Gate-Source Charge	Q_{gs}	V _{GS} = 10 V	$I_D = 9.2 \text{ A}, V_{DS} = 400 \text{ V}$ see fig. 6 and 13 ^b	ı	-	13	nC	
Gate-Drain Charge	Q_{gd}			-	-	20		
Turn-On Delay Time	t _{d(on)}			-	13	-		
Rise Time	t _r	V _{DD} :	= 300 V, I _D = 9.2 A	-	25	-		
Turn-Off Delay Time	t _{d(off)}	$R_g = 9.1 \Omega$	$R_D = 35.5 \Omega$, see fig. 10^b	-	30	-	ns	
Fall Time	t _f]		-	22	-		
Drain-Source Body Diode Characteristic	cs							
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	9.2	٨	
Pulsed Diode Forward Current ^a	I _{SM}			-	-	37	A	
Body Diode Voltage	V _{SD}	$T_J = 25 ^{\circ}\text{C}, I_S = 9.2 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$		-	-	1.5	V	
Body Diode Reverse Recovery Time	t _{rr}	T _ 05 °O 1	_ 0.0 A dI/d+ 100 A/:h	-	530	800	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	$T_J = 25 ^{\circ}\text{C}, I_F = 9.2 \text{A}, dI/dt = 100 \text{A/} \mu \text{s}^{\text{b}}$		-	3.0	4.4	μC	
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D)					L _D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 μ s; duty cycle \leq 2 %.
- c. C_{OSS} eff. is a fixed capacitance that gives the same charging time as C_{OSS} while V_{DS} is rising from 0 to 80% V_{DS} .

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

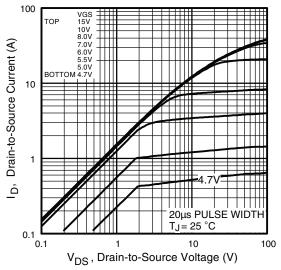
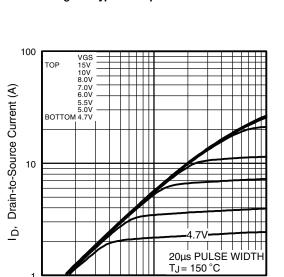


Fig. 1 - Typical Output Characteristics



V_{DS}, Drain-to-Source Voltage (V) Fig. 2 - Typical Output Characteristics

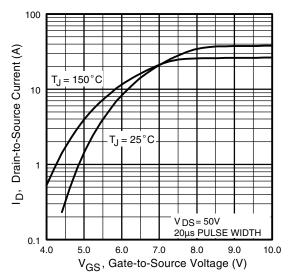


Fig. 3 - Typical Transfer Characteristics

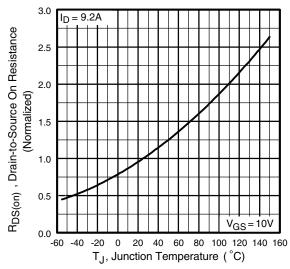


Fig. 4 - Normalized On-Resistance vs. Temperature

100



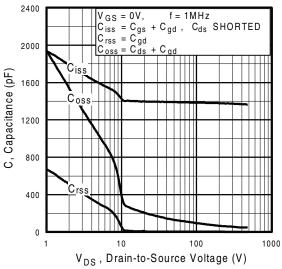


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

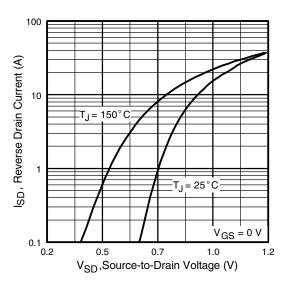


Fig. 7 - Typical Source-Drain Diode Forward Voltage

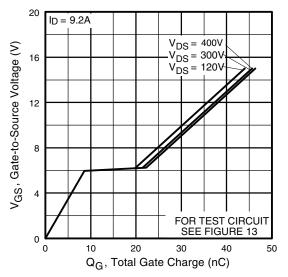


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

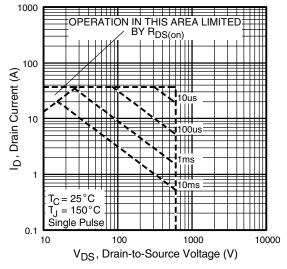


Fig. 8 - Maximum Safe Operating Area



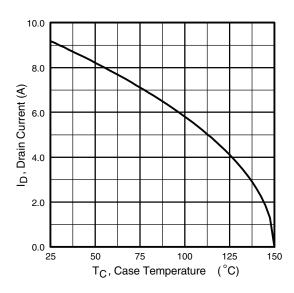


Fig. 9 - Maximum Drain Current vs. Case Temperature

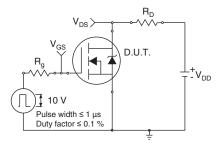


Fig. 10a - Switching Time Test Circuit

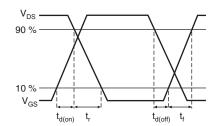


Fig. 10b - Switching Time Waveforms

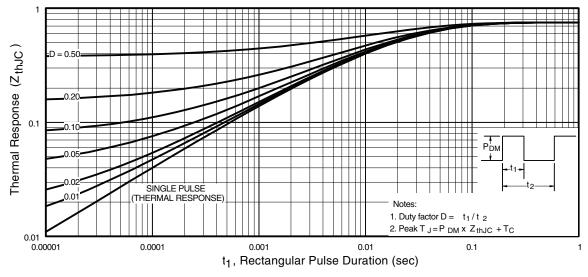


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



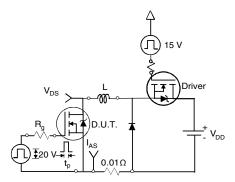


Fig. 12a - Unclamped Inductive Test Circuit

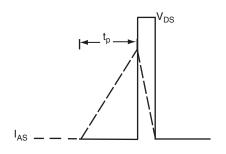


Fig. 12b - Unclamped Inductive Waveforms

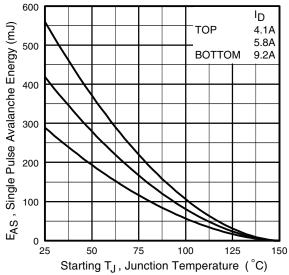


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

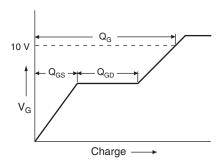


Fig. 13a - Basic Gate Charge Waveform

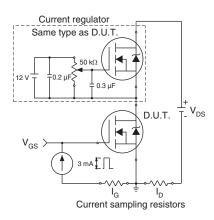
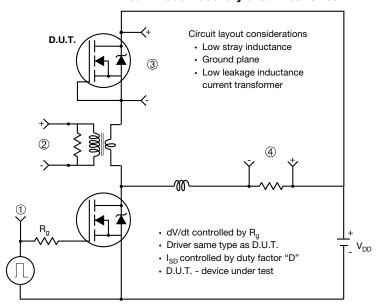


Fig. 13b - Gate Charge Test Circuit

Peak Diode Recovery dV/dt Test Circuit



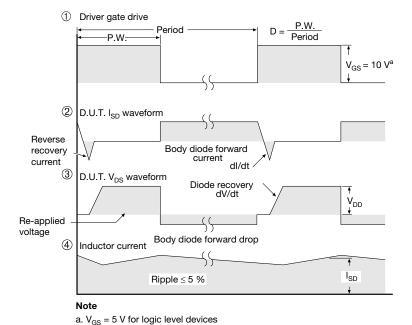


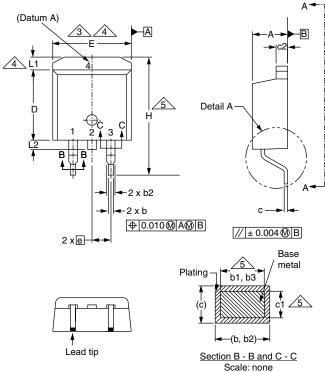
Fig. 14 - For N-Channel

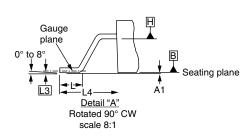
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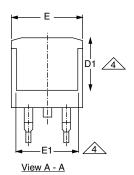
Document Number: 90362 S11-1045-Rev. C, 30-May-11 www.vishay.com



TO-263AB (HIGH VOLTAGE)







(c)	c1 2	<u></u>
	(b, b2)—	
Se	Scale: none	<u>C</u>

	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
Α	4.06	4.83	0.160	0.190
A1	0.00	0.25	0.000	0.010
b	0.51	0.99	0.020	0.039
b1	0.51	0.89	0.020	0.035
b2	1.14	1.78	0.045	0.070
b3	1.14	1.73	0.045	0.068
С	0.38	0.74	0.015	0.029
c1	0.38	0.58	0.015	0.023
c2	1.14	1.65	0.045	0.065
D	8.38	9.65	0.330	0.380
ECN: S-82110-Rev. A, 15-Sep-08				

	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
D1	6.86	-	0.270	-
E	9.65	10.67	0.380	0.420
E1	6.22	-	0.245	-
е	2.54	BSC	0.100 BSC	
Н	14.61	15.88	0.575	0.625
L	1.78	2.79	0.070	0.110
L1	-	1.65	ı	0.066
L2	-	1.78	-	0.070
L3	0.25 BSC		0.010	BSC
L4	4.78	5.28	0.188	0.208

DWG: 5970

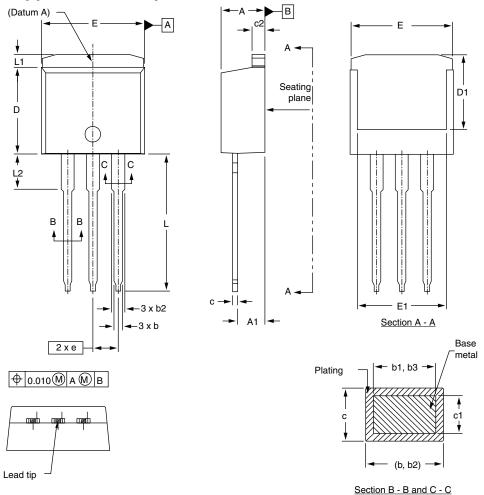
Notes

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Dimensions are shown in millimeters (inches).
- 3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outmost extremes of the plastic body at datum A.
- 4. Thermal PAD contour optional within dimension E, L1, D1 and E1.
- 5. Dimension b1 and c1 apply to base metal only.
- 6. Datum A and B to be determined at datum plane H.
- 7. Outline conforms to JEDEC outline to TO-263AB.

Document Number: 91364 www.vishay.com Revision: 15-Sep-08



I²PAK (TO-262) (HIGH VOLTAGE)



	MILLIMETERS		INC	HES	
DIM.	MIN.	MAX.	MIN.	MAX.	
Α	4.06	4.83	0.160	0.190	
A1	2.03	3.02	0.080	0.119	
b	0.51	0.99	0.020	0.039	
b1	0.51	0.89	0.020	0.035	
b2	1.14	1.78	0.045	0.070	
b3	1.14	1.73	0.045	0.068	
С	0.38	0.74	0.015	0.029	
c1	0.38	0.58	0.015	0.023	
c2	1.14	1.65	0.045	0.065	

	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
D	8.38	9.65	0.330	0.380
D1	6.86	-	0.270	-
E	9.65	10.67	0.380	0.420
E1	6.22	-	0.245	-
е	2.54	BSC	0.100	BSC
L	13.46	14.10	0.530	0.555
L1	-	1.65	-	0.065
L2	3.56	3.71	0.140	0.146

Scale: None

ECN: S-82442-Rev. A, 27-Oct-08

DWG: 5977

Notes

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm per side. These dimensions are measured at the outmost extremes of the plastic body.
- 3. Thermal pad contour optional within dimension E, L1, D1, and E1.
- 4. Dimension b1 and c1 apply to base metal only.

Document Number: 91367 Revision: 27-Oct-08

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